BT169W Series

GENERAL DESCRIPTION

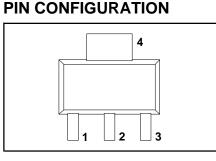
Glass passivated, sensitive gate thyristor in a plastic envelope, suitable for surface mounting, intended for use in general purpose switching and phase control applications. This device is intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

QUICK REFERENCE DATA

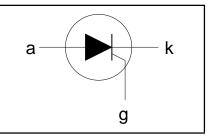
| SYMBOL | PARAMETER | MAX. | MAX. | MAX. | MAX. | UNIT |
|---|---|------------------|------------------|------------------|------------------|--------|
| V _{drm} , V _{rrm} | BT169 Repetitive peak off-state voltages | BW 200 | DW 400 | EW 500 | GW 600 | V |
| I _{T(AV)} | Average on-state | 0.5 | 0.5 | 0.5 | 0.5 | A |
| I _{T(RMS)} I _{TSM} | RMS on-state current Non-repetitive peak on-state current | 0.8 8 | 0.8 8 | 0.8 8 | 0.8 8 | A A |

PINNING - SOT223

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | cathode |
| 2 | anode |
| 3 | gate |
| tab | anode |



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | | MA | λΧ . | | UNIT |
|---|---|---|---------------|------------------------------|------------------------------|------------------------------|------------------------------|--------------------------|
| V_{drm}, V_{rrm} | Repetitive peak off-state voltages | | - | B 200 ¹ | D 400 ¹ | E 500 ¹ | G 600 ¹ | V |
| I _{T(AV)} | Average on-state current | half sine wave; T₅₅ ≤ 112 °C | - | | 0. | 63 | | A |
| I _{T(RMS)} I _{TSM} | RMS on-state current Non-repetitive peak on-state current | all conduction angles half sine wave; $T_i = 25 \degree C$ prior to surge | - | | | 1 | | A |
| | | t = 10 ms t = 8.3 ms | - | | 5 | 3 9 | | A |
| l²t dl _⊤ /dt | I ² t for fusing Repetitive rate of rise of on-state current after triggering | | - | | | 32 0 | | A ² s A/μs |
| I _{GM} V _{GM} V _{RGM} P _{GM} | Peak gate current Peak gate voltage Peak reverse gate voltage Peak gate power | | - - - | | | 1 5 5 2 | | A V V W |
| $\begin{array}{c} P_{G(AV)}^{C(AV)} \\ T_{stg} \\ T_{j} \end{array}$ | Average gate power Storage temperature Operating junction temperature | over any 20 ms period | - -40 - | | 1: | .1 50 25 | | °℃ ℃ |

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the thyristor may switch to the on-state. The rate of rise of current should not exceed 15 $A/\mu s$.

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THERMAL RESISTANCES

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|----------------------|---|---|------|-----------|------|------------|
| R _{th j-sp} | Thermal resistance junction to solder point | | - | - | 15 | K/W |
| R _{th j-a} | | pcb mounted, minimum footprint pcb mounted; pad area as in fig:14 | - | 156 70 | - | K/W K/W |

STATIC CHARACTERISTICS

 $T_i = 25$ °C unless otherwise stated

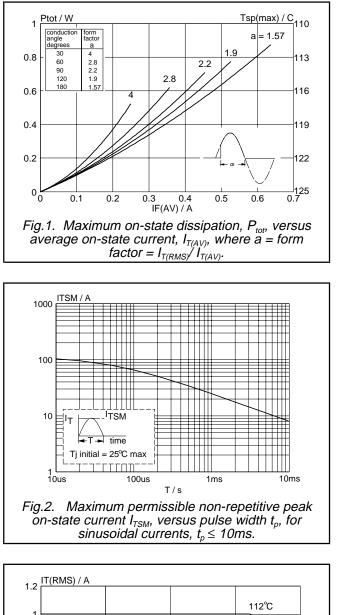
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------------------------|---------------------------|---|------|------|------|------|
| I _{GT} | Gate trigger current | $V_{\rm D}$ = 12 V; I _T = 10 mA; gate open circuit | - | 50 | 200 | μA |
| I _L | Latching current | $V_{\rm D} = 12 \text{ V}; \text{ I}_{\rm GT} = 0.5 \text{ mA}; \text{ R}_{\rm GK} = 1 \text{ k}\Omega$ | - | 2 | 6 | mA |
| I _H | Holding current | $V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.5 \text{ mA}; R_{\rm GK} = 1 \text{ k}\Omega$ | - | 2 | 5 | mA |
| İΫ _T | On-state voltage | $I_T = 2 A$ | - | 1.35 | 1.5 | V |
| V _{GT} | Gate trigger voltage | $\dot{V}_{\rm D}$ = 12 V; I _T = 10 mA; gate open circuit | - | 0.5 | 0.8 | V |
| | | $V_{\rm D} = V_{\rm DRM(max)}; I_{\rm T} = 10 \text{ mA}; T_{\rm j} = 125 \text{ °C};$ | 0.2 | 0.3 | - | V |
| I _D , I _R | Off-state leakage current | gate open circuit $V_D = V_{DRM(max)}, V_R = V_{RRM(max)}; T_j = 125 \text{°C};$ | - | 0.05 | 0.1 | mA |
| | | $R_{GK} = 1 k\Omega$ | | | | |

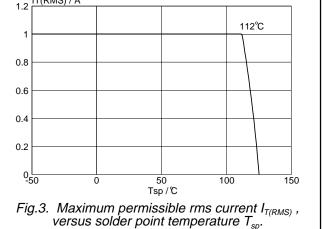
DYNAMIC CHARACTERISTICS

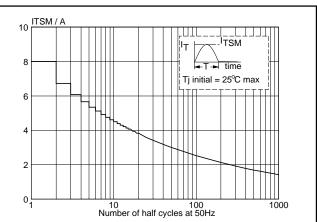
 $T_j = 25$ °C unless otherwise stated

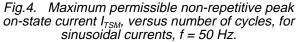
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------------|--|---|------|------|------|------|
| dV _D /dt | Critical rate of rise of off-state voltage | V_{DM} =67% $V_{DRM(max)}$; T _j = 125 °C; exponential waveform; R _{GK} = 1k Ω | - | 25 | - | V/µs |
| t _{gt} | Gate controlled turn-on time | $I_{TM} = 2 \text{ A}; V_D = V_{DRM(max)}; I_G = 10 \text{ mA};$ $dI_G/dt = 0.1 \text{ A}/\mu\text{s}$ | - | 2 | - | μs |
| t _q | Circuit commutated turn-off time | $V_{D}^{"} = 67\% V_{DRM(max)}; T_{i} = 125 °C;$ $I_{TM} = 1.6 A; V_{R} = 35 V; dI_{TM}/dt = 30 A/\mu s;$ $dV_{D}/dt = 2 V/\mu s; R_{GK} = 1 k\Omega$ | - | 100 | - | μs |

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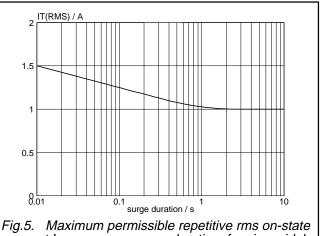
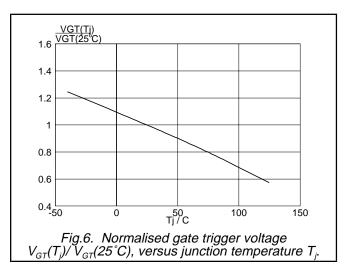
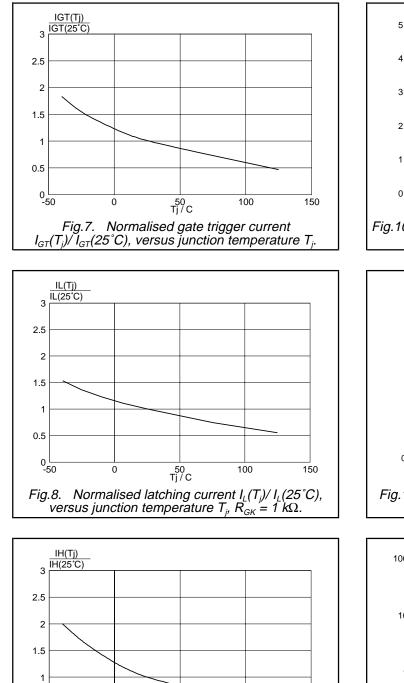
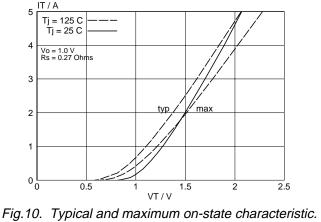


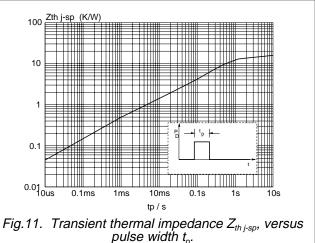
Fig.5. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, f = 50 Hz; $T_{sp} \le 112^{\circ}C$.

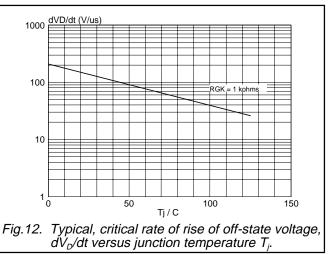


BT169W Series









0.5

0└ -50

0

50 Ti/C

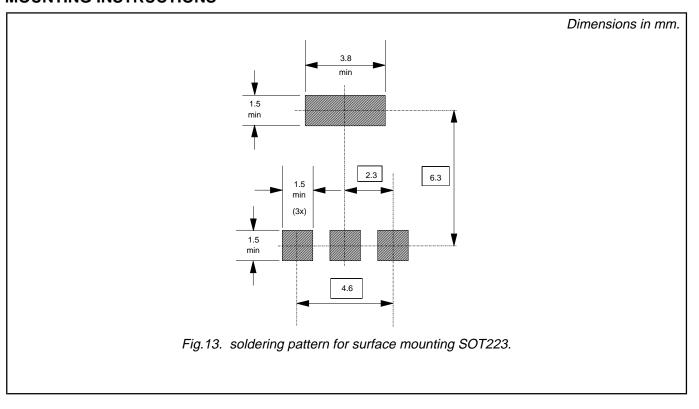
Fig.9. Normalised holding current $I_{H}(T_{j})/I_{H}(25^{\circ}C)$, versus junction temperature T_{j} , $R_{GK} = 1 \ k\Omega$.

100

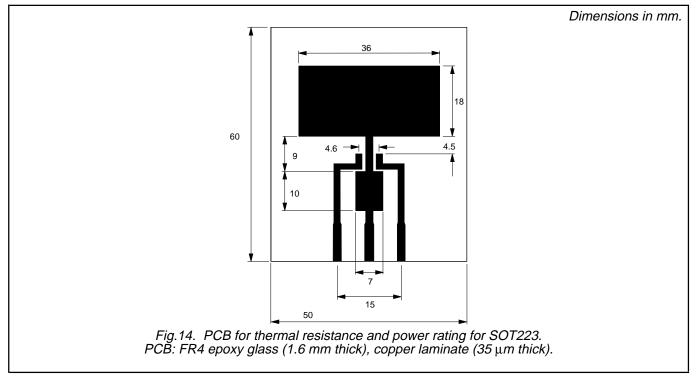
150

BT169W Series

MOUNTING INSTRUCTIONS

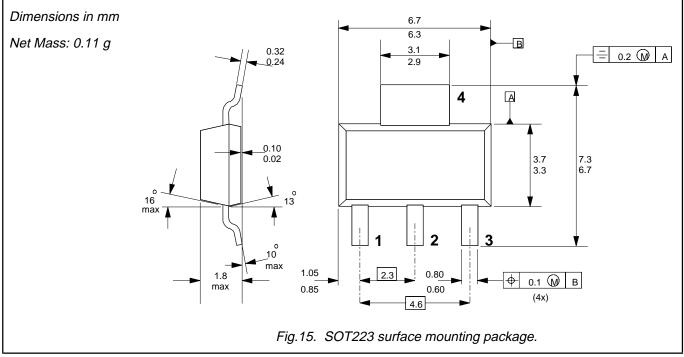


PRINTED CIRCUIT BOARD



BT169W Series

MECHANICAL DATA



Notes

For further information, refer to Philips publication SC18 " SMD Footprint Design and Soldering Guidelines". Order code: 9397 750 00505.
Epoxy meets UL94 V0 at 1/8".

| Thyristor | | BT169W Series |
|-------------|--|----------------------|
| logic level | | |

DEFINITIONS

| Data sheet status | | | |
|--|---|--|--|
| Objective specification This data sheet contains target or goal specifications for product development. | | | |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. | | |
| Product specification | This data sheet contains final product specifications. | | |
| Limiting values | | | |
| Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | | | |
| Application information | | | |
| | | | |

Where application information is given, it is advisory and does not form part of the specification.

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